

Integrated Device Technology, Inc. 6024 Silver Creek Valley Road San Jose, CA 96138

PRODUCT/PROCESS CHANGE NOTICE (PCN)				
PCN #: A0802-01R1 DATE Ma Product Affected: 9.0mm x 9.0mm VFQFP-N-64 10.0mm x 10.0mm VFQFP-N-7 6.1mm x 14.0mm TSSOP-56 6.1mm x 17.0mm TSSOP-64 Date Effective: July 4, 2008	MEANS OF DISTINGUISHING CHANGED DEVICES: □ Product Mark □ Back Mark Lot # will have a "Y" suffix □ Date Code □ Other			
Contact: Bimla Paul	Attachment: Yes No			
Title: Product Quality Assurance Phone #: (408) 574-6419 Fax #: (408) 284-8362 E-mail: Bimla.Paul@idt.com	Samples: Contact your local IDT sales representative for sample requests.			
DESCRIPTION AND PURPOSE OF CHANGE:				
□ Assembly Process □ Equipment ■ Material □ Testing	Revision 1: This notification is a follow-up letter advising our customers that IDT has completed the qualifications on Copper bond wire process for the above mentioned products at Unisem, Indonesia and will start to ship product with copper bond wire process in July 2008. Attachment 1 - outlines the qualification plans and results. Attachment 2 - a copy of the original PCN# A0802-01, issued on April 4, 2008.			
RELIABILITY/QUALIFICATION SUMMARY: There is no expected change to the product quality or	reliability performance.			
to grant approval or request additional information. I it will be assumed that this change is acceptable.	IPT: ation of this change. Please use the acknowledgement below or E-Mail of IDT does not receive acknowledgement within 30 days of this notice attured after the process change effective date until the inventory			
Customer:	☐ Approval for shipments prior to effective date.			
Name/Date:	E-Mail Address:			
Title:	Phone# /Fax# :			
CUSTOMER COMMENTS:				
IDT ACKNOWLEDGMENT OF RECEIPT:				
RECD. BY:	DATE:			

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ATTACHMENT 1 - PCN #: A0802-01R1

PCN Type: Assembly Material Change - Gold wire to Copper wire

Data Sheet Change: None

Detail Of Change:

Revision 1: This notification is a follow-up letter advising our customers that IDT has completed the qualifications on Copper bond wire process for the above mentioned products at Unisem, Indonesia and will start to ship product with copper bond wire process in July 2008. Please refer to the following for qualification plans and results.

Customers may expect to receive shipments no sooner than 90 days from the issued date of the original PCN# A0802-01, April 4, 2008.

Qualification Test Plan and Test Results:

The following tests were successfully completed.

		VFQFP-N	TSSOP
Test Description	Test Method	Test Results (SS / Rej)	Test Results (SS / Rej)
* High Accelerated Stress Test (Biased, 130 °C/85% RH, 100 Hrs)	JESD22-A110-B	45/0	45/0
* Temperature Cycle / Condition B (-55 °C to +125 °C, 1000 Cyc)	JESD22-A104-B	144/0	45/0
High Temp. Storage (150 °C, 1000 Hrs)	JESD22-A103-B	77/0	² 76/0
Ball Shear Test	JESD22-B116	5/0	5/0
Bond Pull Test	IDT Spec, MAC-3010	5/0	5/0
X-ray Examination	IDT Spec, MAC-3012	45/0	45/0

Note:

^{*} Test requires moisture pre-conditioning sequence per JESD22-A113C and will use the existing moisture sensitivity level that has been qualified for this material set at Unisem, Indonesia.

¹ 1 unit - Functional die level failure, not related to Cu Bond process.

² 1 unit - Broken lead hence unable to test at ATE.